PCN Number: 20240		40202001.1		PCN Date:			February 02, 2024		
Title: Qualification of FFAI			B us	B using qualified Process Technology, Die Revision and					
nue.	additional As	sembly	y site	site & BOM options for the LM7171AIMX/NOPB					NOPB
Customer Contact:			Change Management team		Dept:			Quality Services	
						E	stim	ated	
Proposed	1 st Ship Dat	e:	May	y 2, 2024	Sample		-	Mar 2, 2024*	
					Availability:		ility:		
*Sample	requests rec	eived	afte	er March 2, 202	24 will	not	be s	suppo	rted.
Change Ty	ype:								
🛛 Assemb	oly Site		\boxtimes	Design				Wafe	r Bump Material
🔀 Assemb	oly Process		Data Sheet				Wafer Bump Process		
Assembly Materials			Part number change			\square	Wafer Fab Site		
Mechan	ical Specification Test Site						\square	Wafe	r Fab Materials
Packing	J/Shipping/			Test Process			\square	Wafe	r Fab Process
Labelin	g								

PCN Details

Description of Change:

Texas Instruments is pleased to announce the addition of FFAB using the BICOMHD qualified process technology in addition to an Assembly Site option for the LM7171AIMX/NOPB device.

С	urrent Fab Site	e	Additional Fab Site			
Current Fab Site	Process	Wafer Diameter	Additional Fab Site	Process	Wafer Diameter	
DFAB	VIP3	150 mm	FFAB	BICOMHD	200 mm	

The die was also changed as a result of the process change.

Assembly BOM options are noted below:

What	TI Melaka	TI Malaysia
Mold Compound	8095179	4211880
Mount Compound	8075531	4147858
Lead Finish	Matte Sn	NiPdAu
ECAT	G3	G4
Device symbolization - Logo	NSC	TI Letters
Device symbolization – Pin one	dimple	dot

Upon expiry of this PCN, there will be a transition period where TI will combine lead free solutions in a single *standard part number* For example; *LM7171AIMX/NOPB* – can ship with both Matte Sn and NiPdAu.

- Example:
- Customer order for 7500 units of LM7171AIMX/NOPB with 2500 units SPQ (Standard Pack Quantity per Reel).
- TI can satisfy the above order in one of the following ways.
 - I. 3 Reels of NiPdAu finish.
 - II. 3 Reels of Matte Sn finish
 - III. 2 Reels of Matte Sn and 1 reel of NiPdAu finish.
 - IV. 2 Reels of NiPdAu and 1 reel of Matte Sn finish.

Qual details are provided in the Qual Data Section.

Reason for Change:

These changes are part of our multiyear plan to transition products from our 150-millimeter factories to newer, more efficient manufacturing processes and technologies, underscoring our commitment to product longevity and supply continuity.

Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):

None

Impact on Environmental Ratings:

Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.

RoHS	REACH	Green Status	IEC 62474
🛛 No Change	🛛 🖂 No Change	🛛 🛛 No Change	🛛 🖂 No Change
Changes to prod	luct identification resul	ting from this PCN:	

Fab Site

Information:			
Chip Site	Chip Site Origin Code (20L)	Chip Site Country Code (21L)	Chip Site City
DL-LIN-1	DLN	USA	Dallas
FR-BIP-1	TID	DEU	Freising

Die Rev:

Current	New		
Die Rev [2P]	Die Rev [2P]		
A	Α		

Assembly Site Information:

Assembly Site	Assembly Site Origin (22L)	Assembly Country Code (23L)	Assembly City	
TI Melaka	CU6	MYS	Melaka	
TI Malaysia	MLA	MYS	Kuala Lumpur	

Sample product shipping label (not actual product label)

TEXAS INSTRUMENTS MADE IN: Malaysia 2DC: 2Q: MSL '2 /260C/1 YEAR SEAL DT MSL 1 /235C/UNLIM 03/29/04 OPT: ITEM: 39 LBL: 5A (L)T0:1750	(1P) SN74LSO7NSR (Q) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY (1T) 7523483SI2 (P) (2P) REV: (V) 0033317 (20L) CSO: SHE (21L) CCO: MYS (2L) ASO: MLA (23L) ACO: MYS
Product Affected:	
LM7171AIMX/NOPB	

For alternate parts with similar or improved performance, please visit the product page on $\underline{\text{TI.com}}$

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	#	Test Name	Condition	Duration	Qual Device: LM7171AIMX/NOPB	QBS Process Reference: <u>THS3491IDDAR</u>	QBS Package Reference: <u>OPA2810IDR</u>	QBS Package Reference: <u>TCAN1043GDRQ1</u>	QBS Package Reference: <u>TCAN1044VDRQ1</u>	QBS Process Reference: <u>THS2630SDR</u>
HAST	A2	Biased HAST	130C/85%RH	96 Hours	-	3/231/0	3/231/0	-	-	-
UHAST	A3	Autoclave	121C/15psig	96 Hours	-	-	-	3/231/0	3/231/0	-
UHAST	A3	Unbiased HAST	130C/85%RH	96 Hours	-	3/231/0	3/231/0	-	-	-
тс	A4	Temperature Cycle	-65C/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0	3/231/0	-
HTSL	A6	High Temperature Storage Life	170C	420 Hours	-	3/231/0	3/231/0	-	-	-
HTOL	B1	Life Test	140C	480 Hours	-	-	-	-	-	1/77/0
HTOL	B1	Life Test	70C Vcc Max (self heating brings Tj up to 150C)	300 Hours	-	3/231/0	-	-	-	-
ELFR	B2	Early Life Failure Rate	70C (self heating brings Tj up to 150C)	24 Hours	-	3/3000/0	-	-	-	-
Туре	#	Test Name	Condition	Duration	Qual Device: <u>LM7171AIMX/NOPB</u>	QBS Process Reference: <u>THS3491IDDAR</u>	QBS Package Reference: <u>OPA2810IDR</u>	QBS Package Reference: <u>TCAN1043GDRQ1</u>	QBS Package Reference: <u>TCAN1044VDRQ1</u>	QBS Process Reference: <u>THS2630SDR</u>
SD	C3	PB-Free Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-	-	-	-	3/66/0	3/66/0	-
PD	C4	Physical Dimensions	Cpk>1.67	-	-	-	-	3/30/0	3/30/0	-
ESD	E2	ESD CDM	-	250 Volts	1/3/0	3/9/0	1/3/0	-	-	-
ESD	E2	ESD HBM	-	1000 Volts	1/3/0	3/9/0	1/3/0	-	-	-
LU	E4	Latch-Up	Per JESD78	-	1/3/0	3/18/0	1/6/0	-	-	-

OBS: Qual By Similarity

E5

CHAR

Qual Device LM7171AIMX/NOPB is qualified at MSL1 260C

Electrical

Characterization

· Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

1/30/0

• The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

3/90/0

1/30/0

1/30/0

• The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Per

Datasheet

Parameters

TI Qualification ID: R-NPD-2208-065

For questions regarding this notice, e-mails can be sent to the Change Management team or your local Field Sales Representative.

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